## Issue Classification



App	licatio	n/Contro	l No
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Examiner

Hyun, Paul S

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TAKAHASHI ET AL.

Art Unit

1797

ORIGINAL CLASS SUBCLASS					INTERNATIONAL CLASSIFICATION											
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DAMMAR &			Jill Warden  Supervisory Patent Examiner					O.G. Print Claim(s) O.G				O.G. Print Figure				
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